SE7001 · SE7002

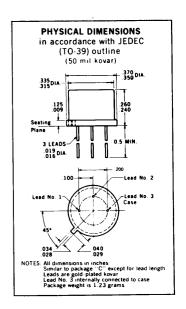
NPN HIGH-VOLTAGE AUDIO / VIDEO AMPLIFIERS

DIFFUSED SILICON PLANAR*TRANSISTORS

The SE7001 and SE7002 are NPN silicon PLANAR transistors designed for use in high-voltage video amplifier and line operated radio audio output applications. They feature low output capacitance and a five watt power rating. These devices are capable of producing up to one watt in highvoltage class "A" audio stages.

ABSOLUTE MAXIMUM RATINGS [Note 1]

Maximum Temperatures					
Storage Temperature	-65°	-65°C to +200°C			
Operating Junction Temperature	200	°C Maximum			
Lead Temperature (Soldering, 60 sec time limit)	300	300°C Maximum			
Maximum Power Dissipation Total Dissipation at 25°C Case Temperature [Notes at 25°C Free Air Temperature [Not	2 and 3] es 2 and 3]	5.0 Watts 0.8 Watt			
Maximum Voltages	SE7001	SE7002			
V _{CBO} Collector to Base Voltage	150 Volts	120 Volts			
V _{CEO} Collector to Emitter Voltage [Note 4]	150 Volts	120 Volts			
V _{EBO} Emitter to Base Voltage	5.0 Volts	5.0 Volts			



ELECTRICAL CHARACTERISTICS (25°C free air temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	-	SE 700 TYP.	MAX.		TYP.		UNITS	TEST CC	NDITIONS
h _{FE} V _{BE} (sat) V _{CE} (sat) h _{fe}	DC Pulse Current Gain [Note 5] Base Saturation Voltage Collector Saturation Voltage Small Signal Current Gain (f = 1.0 kHz)	30 25	60 0.8 0.33 50	0.9 2.0	30 25	60 0.8 0.33 50	0.9 2.0	Volts Volts	$\begin{split} I_c &= 30 \text{ mA} \\ I_c &= 50 \text{ mA} \\ I_c &= 50 \text{ mA} \\ I_c &= 10 \text{ mA} \end{split}$	$V_{CE} = 10 \text{ V} \\ I_{B} = 5.0 \text{ mA} \\ I_{B} = 5.0 \text{ mA} \\ V_{CE} = 5.0 \text{ V}$
h _{fe}	High Frequency Current Gain (f = 20 MHz)	2.0	3.0		2.0	3.0			$I_c = 30 \text{ mA}$	
BV _{CBO}	Collector to Base Breakdown Voltage	150			120				$I_c = 0.1 \text{ mA}$	$I_{\epsilon} = 0$
V _{CEO} (sust)	Collector to Emitter Sustaining Voltage [Note 4]	150			120				I _c = 30 mA (pulsed)	$I_B = 0$

* Planar is a patented Fairchild process.

- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- (3) These ratings give a maximum junction temperature of 200°C and junction to case thermal resistance of 35°C/watt (derating factor of 28.6 mW/°C); junction-to-ambient thermal resistance of 219°C/watt (derating factor of 4.56 mW/°C).
- (4) This rating refers to a high-current point where collector-to-emitter voltage is lowest.
- (5) Pulse Conditions: length = 300 μsec ; duty cycle = 1%.

